

## 12500 TI Boulevard, MS 8640, Dallas, Texas 75243

# PCN#20200605000.1 Oualification of Cu as an alternate bond wire for Select Devices

## **Change Notification / Sample Request**

**Date:** June 12, 2020

To: TOKYO ELECTRON DEVICE (DSTR) PCN

#### Dear Customer:

This is an announcement of a change to a device that is currently offered by Texas Instruments. The details of this change are on the following pages.

We request you acknowledge receipt of this notification within **30** days of the date of this notice. Lack of acknowledgement of this notice within 30 days constitutes acceptance of the change. If you require samples or additional data to support your evaluation, please request within 30 days.

The proposed first ship date is indicated on page 3 of this notification, unless customer agreement has been reached on an earlier implementation of the change.

This notice does not change the end-of-life status of any product. Should product affected be on a previously issued product withdrawal/discontinuance notice, this notification does not extend the life of that product or change the life time buy offering/discontinuance plan.

For questions regarding this notice, contact your local Field Sales Representative or the PCN Team (<u>PCN\_ww\_admin\_team@list.ti.com</u>). For sample requests or sample related questions, contact your field sales representative.

Sincerely,

PCN Team SC Business Services

### 20200605000.1 Attachment: 1

### **Products Affected:**

The devices listed on this page are a subset of the complete list of affected devices. According to our records, these are the devices that you have purchased within the past twenty-four (24) months. The corresponding customer part number is also listed, if available.

**DEVICE**DRV401AIRGWR

**CUSTOMER PART NUMBER** 

null

Technical details of this Product Change follow on the next page(s).

PCN Number:		20200605000.1					PCN D	ate:	June 12, 2020		
Title: Qualifica		ation of Cu as an alternate bond wire for select dev					vices				
Cus	tomer Conta	ct: PCN /	t: PCN Manager Dept:				Quality Services				
Proposed 1 <sup>st</sup> Shi		p Date: Sept. 10		10,	), 2020 <b>Es</b>		timated Sample Availability:		Date provided at sample request		
Cha	inge Type:										
	Assembly Site			Design			Wafer Bump Site				
$\boxtimes$					☐ Data Sheet			Wafer Bump Material			
$\boxtimes$	Assembly Materials				Part number change			Wafer Bump Process			
	Mechanical Specification			-=-	Test Site			Wafer Fab Site			
	Packing/Shipping/Labeling				Test Pr	ocess		Wafer Fab Materials			
								Wafer Fab Process			
					PCN	Details					
Des	cription of C	hange:									
This PCN is to inform of an alternative bond wire qualification for the devices in the product affected section as follows:											
	Devic	e Group				t Bond wire,			nal Bond wire,		
						iameter			diameter		
	RGW		Au, 0.96 mils				Cu, 1.0 mils				
	_										
		ORZ			Au,	0.80 mils		Cı	ı, 0.8 mils		
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#### Qualification Results Data Displayed as: Number of lots / Total sample size / Total failed

Туре	Test Name / Condition	Duration	Qual Device: DRV401AIRGWR	Qual Device: SN27411DRZR-B1	QBS Package Reference: <u>MUX36D04IRUM</u>	QBS Package Reference: <u>MUX36S08IRUM</u>	QBS Package Reference: <u>TPS25740BRGE</u>
AC	Autoclave 121C	96 Hours	3/231/0	3/231/0	1/77/0	2/154/0	-
CDM	ESD - CDM	1000 V	-	-	1/3/0	1/3/0	1/3/0
ED	Electrical Characterization	Per Datasheet Parameters	-	-	Pass	Pass	PASS
HAST	Biased HAST, 130C/85%RH	96 Hours	-	-	1/77/0	2/154/0	3/231/0
HBM	ESD - HBM	4000 V	-	-	1/3/0	1/3/0	1/3/0
HTOL	Life Test, 125C	1000 Hours	-	-	-	-	1/77/0
HTSL	High Temp Storage Bake 170C	420 Hours	-	-	1/77/0	2/154/0	3/231/0
LU	Latch-up	( Per JESD78)	-	-	1/6/0	1/6/0	1/6/0
TC	Temperature Cycle, - 65/150C	500 Cycles	3/231/0	3/231/0	1/77/0	2/154/0	3/231/0
UHAST	Unbiased HAST 130C/85%RH	96 Hours	-	-	-	-	3/231/0
WBP	Bond Pull	Wires	3/228/0	3/228/0	1/76/0	2/152/0	-
WBS	Ball Bond Shear	Wires	3/228/0	3/228/0	1/76/0	2/152/0	-

- Preconditioning was performed for Autoclave, Unbiased HAST, THB/Biased HAST, Temperature Cycle, Thermal Shock, and HTSL, as applicable
   The following are equivalent HTOL options based on an activation energy of 0.7eV: 125C/1k Hours, 140C/480 Hours, 150C/300 Hours, and 155C/240 Hours
- The following are equivalent HTSL options based on an activation energy of 0.7eV: 150C/1k Hours, and 170C/420 Hours The following are equivalent Temp Cycle options per JESD47: -55C/125C/700 Cycles and -65C/150C/500 Cycles

Quality and Environmental data is available at TI's external Web site: http://www.ti.com/

Green/Pb-free Status:

Qualified Pb-Free(SMT) and Green

For questions regarding this notice, e-mails can be sent to the contacts shown below or your local Field Sales Representative.

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